IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS:	Smith et. al.	GROUP NO.:	Not yet assigned

APPLICATION NO.: Not yet assigned EXAMINER: Not yet assigned

FILING DATE: Herewith CONF. NO.: Not yet assigned

TITLE: Laser-Driven Light Source

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Madam:

In accordance with the provisions of 37 C.F.R. § 1.98(d) copies of the references are not enclosed as these references were previously cited by or submitted to the U.S. Patent and Trademark Office in a prior application (U.S. Serial No. 13/024,027; U.S. Serial No. 12/166,918; U.S. Serial No. 11/695,348 and U.S. Serial No. 11/295,523) that is relied upon for an earlier filing date under 35 U.S.C. § 120 and 121.

Submission of any document(s), publication(s) or reference(s) herewith does not imply concession by Applicant(s) to any characterization of the document(s), publication(s) or reference(s) (including any statements therein), and no such concession is made.

Applicants authorize the Commissioner to charge any necessary fees due in connection with the Information Disclosure Statement filed herewith to Deposit Account No. 50-3081.

REMARKS

In accordance with the provisions of 37 C.F.R. 1.97, this statement is being filed (check one)

(1)	within three (3) months of the filing date of a national application prosecution application under 37 C.F.R. 1.53(d), or within three entry of the national stage as set forth in 37 C.F.R. 1.491 in an or before the mailing of the first Office action on the merits, or first Office action after the filing of a request for continued examination.	e (3) months of the date of in international application, before the mailing of a
(2)	after the period defined in (1) but before the mailing date of a fi allowance under 37 C.F.R. 1.311, and	nal action or a notice of
	the requisite Statement is below, OR	ASML 1024



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		the requ	nisite fee under 37 C.F.R. 1.17(p), namely \$180.00, is included herein, or					
	(3)	after the mailing date of a final action or notice of allowance but on or before the payment of the issue fee, AND						
		the requ	uisite Statement is below, AND					
		the requ	uisite fee under 37 C.F.R. 1.17(p), namely \$180.00, is included herein.					
PTO-14		-	requested that each of the patents and publications listed on the attached Form formation contained herein, be made of record in this application.					
			STATEMENT					
that:	As requ	iired und	der 37 C.F.R. 1.97(e), Applicant(s), through the undersigned, hereby state either					
		1.	Each item of information contained in the Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Information Disclosure Statement; or					
		2.	No item of information contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing this Statement after making reasonable inquiry, no item of information contained in the Information Disclosure Statement was known to any individual designated in 37 C.F.R. 1.56(c) more than three months prior to the filing of the Information Disclosure Statement.					
			Respectfully submitted,					
Data	Angust	12 201	PROSKAUER ROSE LLP					
	August Io.: 45,2		Gerald E. Worth, P.E.					
Proskauer Rose LLP Tel. No.: (617) 526-9626 Fax No.: (617) 526-9899 Proskauer Rose LLP Attorney for the Applicant One International Place								



Boston, MA 02110

FORM PTO – 1449

INFORMATION DISCLOSURE STATEMENT

ATTY DOCKET NO.: EGQ-005CP3C1

APPLICANTS: Smith et al.

APPLICATION NO.: Not yet assigned

FILING DATE: Herewith

GROUP: Not yet assigned

U.S. PATENT DOCUMENTS

EXAM INIT.		DOCUMENT NO.	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	A1	4,088,966	05/09/1978	Samis			
	A2	4,152,625	05/1979	Conrad, Raymond W.			
	A3	4,498,029	02/05/1985	Yoshizawa et al.			
	A4	4,646,215	2/24/1987	Levin et al.			
	A5	6,288,780	09/11/01	Fairley et al.			
	A6	6,417,625	07/09/2002	Brooks et al.			
	A7	6,788,404	09/07/04	Lange			
	A8	6,956,329	10/18/2005	Brooks et al.			
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	A11	7,429,818	09/30/2008	Chang et al.			
	A12	7,652,430	01/26/2010	Delgado			
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	A15	2002/0021508	2/21/2002	Ishihara			
	A16	2003/0168982	9/11/2003	Kim			
	A17	2003/0231496	12/18/2003	Sato et al.			
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	A19	2004/0264512	12/30/2004	Hartlove et al.			
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	A22	2007/0228300	10/04/2007	Smith, Donald K.			



FORM I	РΤΟ –	1449					A'	TTY DOC	KET N	1O.:	EGQ-0	05CP3	C1	
					APPLICANTS:			Smith o	Smith et al.					
INFORMATION DISCLOSURE STATEMENT					Γ	APPLICATION NO.:				Not yet assigned				
						FILING DATE:			Herewith					
							Gl	ROUP:			Not yet	t assigr	ned	
	A23	2007/0285921		12/13/2007 Zulim		n et al.								
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				FOR	EIG	N PA	TE:	NT DOCU	JMEN	TS				
EXAM INIT.		DOCUMENT NO.	DA	ТЕ	CO	UNTR' DE	Y	CLASS	SUB CLAS	SUB CLASS		ABS ONI	TRACT Y	ENGLISH LANG (Y/N)
	B1	04-144053	05/	18/1992	JP							N		Y (abstract only)
	B2	08-299951	11/	19/1996	JP						N		Y (abstract only)	
	В3	61 193358	08/	27/1986	/1986 JP							No		Y
	В4	2010/093903	08/	19/2010	WO)						Yes		Yes
			O	THER.	ART	r, JOU	JRN	NAL ART	ICLE	S, E	TC.			
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	C1	Beck, "Simple Pulse Generator for Pulsing Xenon Arcs with High Repetition Rate," <u>Rev. Sci. Instrum.</u> , Vol. 45, No. 2, February, 1974, pp. 318-319.												
	C2	Bussiahn, R., et. al., "Experimental and theoretical investigations of a low-pressure He-Xe discharge for lighting purpose," Journal of Applied Physics, Vol. 95, No. 9, May 1, 2004, pages 4627-4634												
	С3	Carlhoff et al., "Continuous Optical Discharges at Very High Pressure," Physica 103C, 1981, pp. 439-447.												
	C4	Cremers et al., "Evaluation of the Continuous Optical Discharge for Spectrochemical Analysis," Spectrochimica Acta, Vol. 40B, No. 4, 1985, pp. 665-679.												
	C5	Fiedorowicz et al., "X-Ray Emission form Laser-Irradiated Gas Puff Targets," <u>Appl. Phys. Lett.</u> 62 (22), May 31, 1993, pp. 2778-2780.												
	C6	Franzen, "CW Gas Breakdown in Argon Using 10.6-µm Laser Radiation," Appl. Phys. Lett., Vol. 21, No. 2, July 15, 1972, pp. 62-64.												
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	C8	Generalov et al., "Experimental Investigation of a Continuous Optical Discharge," <u>Soviet Physics JETP</u> , Vol. 34, No. 4, April, 1972, pp. 763-769.												



FORM PTO –	1449	ATTY DOCKET NO.: EGQ-005CP3C1					
		APPLICANTS:	Smith et al.				
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		FILING DATE:					
		GROUP:	Not yet assigned				
С9	Hamamatsu Product Information, "Super-Quiet	Xenon Lamp Super-Quiet Mercury-Xenon Lamp," November, 2005. pp. 1-16.					
C10	Hecht, "Refraction", Optics (Third Edition),	1998, Chapter 4, pp. 100-101.					
C11	Jeng et al., "Theoretical Investigation of Laser-S 2279.	Sustained Argon Plasmas," <u>J. Ap</u>	pl. Phys. 60 (7), October 1, 1986, pp. 2272-				
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C13	Keefer, "Laser-Sustained Plasmas," <i>Laser-Induced Plasmas and Applications</i> , published by Marcel Dekker, edited by Radziemski et al., 1989, pp. 169-206.						
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C17	Nakr, "Radiometric Characterization of Ultrahigh Radiance Xenon Short-acr Dichage Lamps", <u>Applied Optics</u> , Vol. 47, No. 2, January 9, 2008, Pages 224-229						
C18	Raĭzer, "Optical Discharges," <u>Sov. Phys. Usp.</u> 23(11), Nov., 1980, pp. 789-806.						
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